## Application/Control No. Applicant(s)/Patent Under Reexamination 10/509,469 IDE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Deborah Yee 1742 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,641,780 11-2003 Grubb, John F. 420/68 Α US-В US-C US-D US-Ε US-F US-G US-H, US-١ US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν o Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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